

Linear Integrated Systems

LS OP-37

FEATURES:

- Replaces AD-510, 517, 725
PMI-Op27, Op37, Op07, Op05
Linear Tech. Op27, Op37, Op07
- Low Noise $3\text{nV}/\sqrt{\text{Hz}}$ @ 1kHz
 8OnVpp (0.1Hz to 10Hz)
- Low Drift $0.2\mu\text{V}/^\circ\text{C}$
- Low Vos $10\mu\text{V}$
- Slew Rate $17\text{V}/\mu\text{s}$
- High Open Loop Gain 1.8 Meg.
- Gain Bandwidth 63 Meg Hz
- Superior CMRR 126dB @ V_{cm} of $\pm 11\text{V}$

DESCRIPTION:

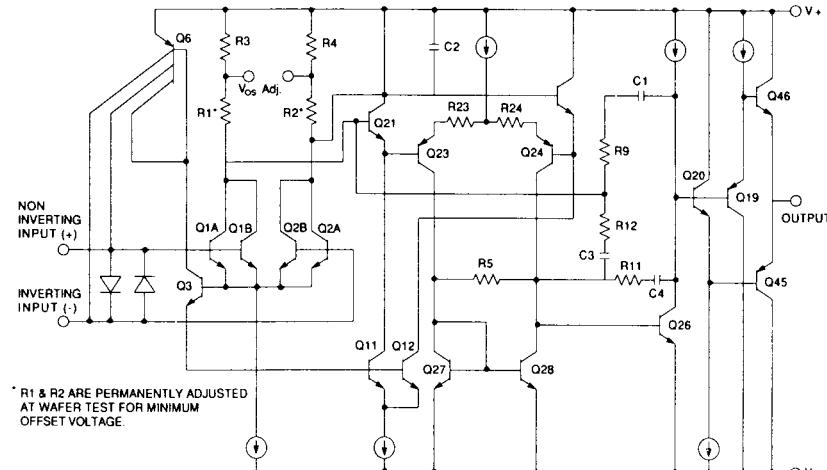
The Op-37 provides the same high performance as the Op-27 but the design is optimized for circuits with gains greater than five. This design change increases slew rate to $17\text{V}/\mu\text{s}$ and gain-bandwidth product to 63MHz. The Op-37 operational amplifier combines outstanding low noise performance with precision D.C. characteristics and high speed operation. Wideband noise is $3\text{nV}/\sqrt{\text{Hz}}$ at 10Hz., with a low 1/f noise corner frequency of 2.7Hz. The Op-37's exceptionally low noise process allows for accurate high-gain amplification of low level signals. A gain-bandwidth product of 63MHz and a $17\text{V}/\mu\text{sec}$ slew rate provides excellent choice for reliable,

precision amplifier applications. The low input bias current of 10nA and offset current of 7nA are achieved by using a bias-current-cancellation circuit. Over the military temperature range this typically holds I-bias and I-os to 20nA and 15nA respectively. PSRR and CMRR exceed 120dB. These characteristics coupled with long-term drift of $0.2\mu\text{V}/\text{month}$, allow the circuit designer to achieve performance levels previously attained by discrete designs.

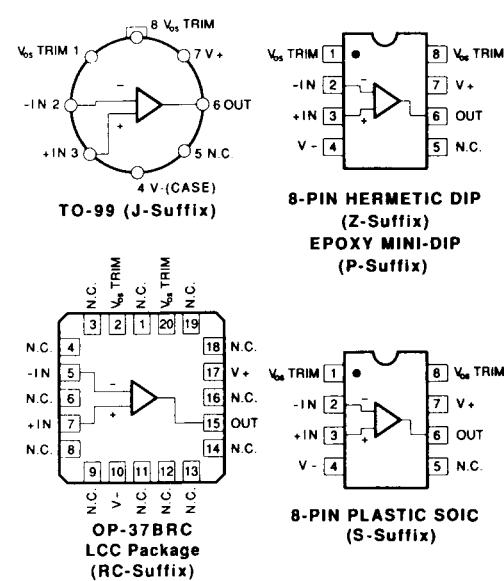
PRODUCT HIGHLIGHTS:

1. Precision amplification of very low level, low frequency voltage inputs is enhanced by ultra-low input voltage noise.
2. The Op-37 maintains high dc accuracy due to ultra-low offset voltage, offset voltage drift and input bias current.
3. Internal frequency compensation, factory adjusted offset voltage (zener-zapped) and full device protection eliminate the need for additional components.
4. Long-term stability and accuracy is assured with low offset voltage drift over time.
5. Input errors are greatly reduced by superior common mode and power supply rejection.
6. Radiation hardenable; contact factory.

SIMPLIFIED SCHEMATIC



PIN CONNECTIONS



Linear Integrated Systems

LS OP-37

ABSOLUTE MAXIMUM RATINGS (Note 4)

| | | |
|-------------------------------------|-------|-----------------|
| Supply Voltage | | ± 22 |
| Internal Power Dissipation (Note 1) | | 500mW |
| Input Voltage (Note 3) | | $\pm 22V$ |
| Output Short-Circuit Duration | | Indefinite |
| Differential Input Voltage (Note 2) | | $\pm 0.7V$ |
| Differential Input Current (Note 2) | | $\pm 25mA$ |
| Storage Temperature Range | | -65°C to +150°C |

Operating Temperature

| | | |
|--|-------|-----------------|
| Op-37A, Op-37B, Op-37C (J, Z, RC) | | -55°C to +125°C |
| Op-37E, Op-37F, Op-37G (J, Z) | | -25°C to +85°C |
| Op-37E, Op-37F, Op-37G (P, S) | | 0°C to +70°C |
| Lead Temperature Range (Soldering, 60 sec) | | 300°C |
| DICE Junction Temperature | | -65°C to +150°C |

NOTES:

- See table for maximum ambient temperature rating and derating factor.

| PACKAGE TYPE | MAXIMUM AMBIENT TEMPERATURE FOR RATING | DERATE ABOVE MAXIMUM AMBIENT TEMPERATURE |
|------------------------|--|--|
| T0-99 (J) | 80°C | 7.1mW/°C |
| 8-Pin Hermetic DIP (Z) | 75°C | 6.7mW/°C |
| 8-Pin Plastic SOIC (S) | 62°C | 5.6mW/°C |
| 8-Pin Plastic DIP (P) | 62°C | 5.7mW/°C |
| LCC | 80°C | 7.8mW/°C |

- The OP-37's inputs are protected by back-to-back diodes. Current limiting resistors are not used in order to achieve low noise. If differential input voltage exceeds $\pm 0.7V$, the input current should be limited to 25mA.
- For supply voltages less than $\pm 22V$, the absolute maximum input voltage is equal to the supply voltage.
- Absolute maximum ratings apply to both DICE and packaged parts, unless otherwise noted.
- If Military/Aerospace specified devices are required, contact the Linear Systems Sales Office for availability and specifications.

ELECTRICAL CHARACTERISTICS at $V_S = \pm 15V$, $T_A = 25°C$, unless otherwise noted.

| PARAMETER | SYMBOL | CONDITIONS | OP-37A/E | | | OP-37B/F | | | OP-37C/G | | | UNITS |
|--------------------------------------|---------------|--|------------|------------|----------|------------|------------|----------|------------|------------|----------|----------------|
| | | | MIN | TYP | MAX | MIN | TYP | MAX | MIN | TYP | MAX | |
| Input Offset Voltage | V_{OS} | (Note 1) | — | 10 | 25 | — | 20 | 60 | — | 30 | 100 | μV |
| Long-Term V_{OS} Stability | $V_{OS}/Time$ | (Notes 2, 3) | — | 0.2 | 1.0 | — | 0.3 | 1.5 | — | 0.4 | 2.0 | $\mu V/Mo$ |
| Input Offset Current | I_{OS} | | — | 7 | 35 | — | 9 | 50 | — | 12 | 75 | nA |
| Input Bias Current | I_B | | — | ± 10 | ± 40 | — | ± 12 | ± 55 | — | ± 15 | ± 80 | nA |
| Input Noise Voltage | e_{npp-p} | 0.1Hz to 10Hz (Notes 3, 5) | — | 0.08 | 0.18 | — | 0.08 | 0.18 | — | 0.09 | 0.25 | μV_{pp-p} |
| Input Noise Voltage Density | e_n | $f_O = 10Hz$ (Note 3) | — | 3.5 | 5.5 | — | 3.5 | 5.5 | — | 3.8 | 8.0 | |
| | | $f_O = 30Hz$ (Note 3) | — | 3.1 | 4.5 | — | 3.1 | 4.5 | — | 3.3 | 5.6 | nV/\sqrt{Hz} |
| | | $f_O = 1000Hz$ (Note 3) | — | 3.0 | 3.8 | — | 3.0 | 3.8 | — | 3.2 | 4.5 | |
| Input Noise Current Density | i_n | $f_O = 10Hz$ (Notes 3, 6) | — | 1.7 | 4.0 | — | 1.7 | 4.0 | — | 1.7 | — | |
| | | $f_O = 30Hz$ (Notes 3, 6) | — | 1.0 | 2.3 | — | 1.0 | 2.3 | — | 1.0 | — | pA/\sqrt{Hz} |
| | | $f_O = 1000Hz$ (Notes 3, 6) | — | 0.4 | 0.6 | — | 0.4 | 0.6 | — | 0.4 | 0.6 | |
| Input Resistance — Differential-Mode | R_{IN} | (Note 7) | 1.3 | 6 | — | 0.94 | 5 | — | 0.7 | 4 | — | $M\Omega$ |
| Input Resistance — Common-Mode | R_{INCM} | | — | 3 | — | — | 2.5 | — | — | 2 | — | $G\Omega$ |
| Input Voltage Range | IVR | | ± 11.0 | ± 12.3 | — | ± 11.0 | ± 12.3 | — | ± 11.0 | ± 12.3 | — | V |
| Common-Mode Rejection Ratio | CMRR | $V_{CM} = \pm 11V$ | 114 | 126 | — | 106 | 123 | — | 100 | 120 | — | dB |
| Power Supply Rejection Ratio | PSSR | $V_S \pm 4V$ to $\pm 18V$ | — | 1 | 10 | — | 1 | 10 | — | 2 | 20 | $\mu V/V$ |
| Large-Signal Voltage Gain | A_{vO} | $R_L \geq 2k\Omega$, $V_O = \pm 10V$ | 1000 | 1800 | — | 1000 | 1800 | — | 700 | 1500 | — | |
| | | $R_L \geq 1k\Omega$, $V_O = \pm 10V$ | 800 | 1500 | — | 800 | 1500 | — | 400 | 1500 | — | V/mV |
| | | $R_L = 600\Omega$, $V_O \pm 1V$, $V_S = \pm 4V$, (Note 4) | 250 | 700 | — | 250 | 700 | — | 200 | 500 | — | |
| Output Voltage Swing | V_O | $R_L \geq 2k\Omega$ | ± 12.0 | ± 13.8 | — | ± 12.0 | ± 13.8 | — | ± 11.5 | ± 13.5 | — | V |
| | | $R_L \geq 600\Omega$ | ± 10.0 | ± 11.5 | — | ± 10.0 | ± 11.5 | — | ± 10.0 | ± 11.5 | — | |
| Slew Rate | SR | $R_L \geq 2k\Omega$ (Note 4) | 11 | 17 | — | 11 | 17 | — | 11 | 17 | — | $V/\mu s$ |
| Gain Bandwidth Prod. | GBW | $f_O = 10kHz$ (Note 4) | 45 | 63 | — | 45 | 63 | — | 45 | 63 | — | Mhz |
| | | $f_O = 1MHz$ | — | 40 | — | — | 40 | — | — | 40 | — | |
| Open-Loop Output Resistance | R_O | $V_O = 0$, $I_O = 0$ | — | 70 | — | — | 70 | — | — | 70 | — | Ω |
| Power Consumption | P_d | $V_O = 0$ | — | 90 | 140 | — | 90 | 140 | — | 100 | 170 | mW |
| Offset Adjustment Range | | $R_p = 10k\Omega$ | — | ± 4.0 | — | — | ± 4.0 | — | — | ± 4.0 | — | mV |

NOTES:

- Input offset voltage measurements are performed by automated test equipment approximately 0.5 seconds after application of power. A/E grades guaranteed fully warmed up.
- Long-term input offset voltage stability refers to the average trend line of V_{OVS} . Time over extended periods after the first 30 days of operation. Excluding the initial hour of operation, changes in V_{OVS} during the first 30

days are typically $2.5\mu V$ — refer to typical performance curve.

3. Sample tested.

4. Guaranteed by design.

5. See test circuit and frequency response curve for 0.1Hz tester.

6. See test circuit for current noise measurement.

7. Guaranteed by input bias current.

ELECTRICAL CHARACTERISTICS for $V_S = \pm 15V$, $-55^\circ C \leq T_A \leq +125^\circ C$, unless otherwise noted.

| PARAMETER | SYMBOL | CONDITIONS | OP-37A | | | OP-37B | | | OP-37C | | | UNITS |
|------------------------------|------------|---------------------------------------|------------|------------|----------|------------|------------|----------|------------|------------|-----------|------------------|
| | | | MIN | TYP | MAX | MIN | TYP | MAX | MIN | TYP | MAX | |
| Input Offset Voltage | V_{OS} | (Note 1) | — | 30 | 60 | — | 50 | 200 | — | 70 | 300 | μV |
| Average Input Offset Drift | TCV_{OS} | (Note 2) | — | 0.2 | 0.6 | — | 0.3 | 1.3 | — | 0.4 | 1.8 | $\mu V/^\circ C$ |
| Input Offset Current | I_{OS} | | — | 15 | 50 | — | 22 | 85 | — | 30 | 135 | nA |
| Input Bias Current | I_B | | — | ± 20 | ± 60 | — | ± 28 | ± 95 | — | ± 35 | ± 150 | nA |
| Input Voltage Range | IVR | | ± 10.3 | ± 11.5 | — | ± 10.3 | ± 11.5 | — | ± 10.2 | ± 11.5 | — | V |
| Common-Mode Rejection Ratio | CMRR | $V_{CM} = \pm 10V$ | 108 | 122 | — | 100 | 119 | — | 94 | 116 | — | dB |
| Power Supply Rejection Ratio | PSRR | $V_S = \pm 4.5V$ to $\pm 18V$ | — | 2 | 16 | — | 2 | 20 | — | 4 | 51 | $\mu V/V$ |
| Large-Signal Voltage Gain | A_{VO} | $R_L \geq 2k\Omega$, $V_O = \pm 10V$ | 600 | 1200 | — | 500 | 1000 | — | 300 | 800 | — | V/mV |
| Output Voltage Swing | V_O | $R_L \geq 2k\Omega$ | ± 11.5 | ± 13.5 | — | ± 11.0 | ± 13.2 | — | ± 10.5 | ± 13.0 | — | V |

ELECTRICAL CHARACTERISTICS for $V_S = \pm 15V$, $-25^\circ C \leq T_A \leq +85^\circ C$ for OP-37J and OP-37Z, $0^\circ C \leq T_A \leq +70^\circ C$ for OP-37P, unless otherwise noted.

| PARAMETER | SYMBOL | CONDITIONS | OP-37E | | | OP-37F | | | OP-37G | | | UNITS |
|------------------------------|------------|---------------------------------------|------------|------------|----------|------------|------------|----------|------------|------------|-----------|------------------|
| | | | MIN | TYP | MAX | MIN | TYP | MAX | MIN | TYP | MAX | |
| Input Offset Voltage | V_{OS} | | — | 20 | 50 | — | 40 | 140 | — | 55 | 220 | μV |
| Average Input Offset Drift | TCV_{OS} | (Note 2) | — | 0.2 | 0.6 | — | 0.3 | 1.3 | — | 0.4 | 1.8 | $\mu V/^\circ C$ |
| Input Offset Current | I_{OS} | | — | 10 | 50 | — | 14 | 85 | — | 20 | 135 | nA |
| Input Bias Current | I_B | | — | ± 14 | ± 60 | — | ± 18 | ± 95 | — | ± 25 | ± 150 | nA |
| Input Voltage Range | IVR | | ± 10.5 | ± 11.8 | — | ± 10.5 | ± 11.8 | — | ± 10.5 | ± 11.8 | — | V |
| Common-Mode Rejection Ratio | CMRR | $V_{CM} = \pm 10V$ | 110 | 124 | — | 102 | 121 | — | 96 | 118 | — | dB |
| Power Supply Rejection Ratio | PSRR | $V_S = \pm 4.5V$ to $\pm 18V$ | — | 2 | 15 | — | 2 | 16 | — | 2 | 32 | $\mu V/V$ |
| Large-Signal Voltage Gain | A_{VO} | $R_L \geq 2k\Omega$, $V_O = \pm 10V$ | 750 | 1500 | — | 700 | 1300 | — | 450 | 1000 | — | V/mV |
| Output Voltage Swing | V_O | $R_L \geq 2k\Omega$ | ± 11.7 | ± 13.6 | — | ± 11.4 | ± 13.5 | — | ± 11.0 | ± 13.3 | — | V |

NOTES:

1. Input offset voltage measurements are performed by automated test equipment approximately 0.5 seconds after application of power. A/E grades guaranteed fully warmed up.

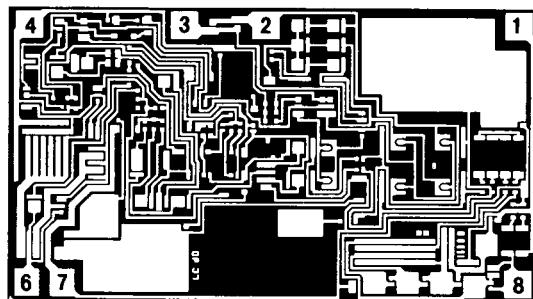
2. The TCV_{OS} performance is within the specifications unnullled or when nulled with $R_p = 8k\Omega$ to $20k\Omega$. TCV_{OS} is 100% tested for A/E grades, sample tested for B/C/F/G grades.

3. Guaranteed by design.

DICE CHARACTERISTICS

DIE SIZE 0.057x0.099 inch, 5643 sq. mils
(1.44x2.57mm, 3.62 sq. mm)

For additional DICE information contact factory.



1. NULL
2. (-) INPUT
3. (+) INPUT
4. V-
6. OUTPUT
7. V+
8. NULL

Linear Integrated Systems

LS OP-37

WAFER TEST LIMITS at $V_S = \pm 15V$, $T_A = 25^\circ C$ for OP-37N, OP-37G and OP-37GR devices; $T_A = 125^\circ C$ for OP-37NT and OP-37GT devices, unless otherwise noted.

| PARAMETER | SYMBOL | CONDITIONS | OP-37NT LIMIT | OP-37N LIMIT | OP-37GT LIMIT | OP-37G LIMIT | OP-37GR LIMIT | UNITS |
|------------------------------|----------|---|------------------|--------------------------|------------------|--------------------------|--------------------------|---------------|
| Input Offset Voltage | V_{os} | (Note 1) | 60 | 35 | 200 | 60 | 100 | μV MAX |
| Input Offset Current | I_{os} | | 50 | 35 | 85 | 50 | 75 | nA MAX |
| Input Bias Current | I_B | | ± 60 | ± 40 | ± 95 | ± 55 | ± 80 | nA MAX |
| Input Voltage Range | IVR | | ± 10.3 | ± 11 | ± 10.3 | ± 11 | ± 11 | V MIN |
| Common-Mode Rejection Ratio | CMRR | $V_{CM} = \pm 11V$ | 108 | 114 | 100 | 106 | 100 | dB MIN |
| Power Supply Rejection Ratio | PSRR | $T_A = 25^\circ C$, $V_S = \pm 4V$ to $\pm 18V$ $T_A = 125^\circ C$, $V_S = \pm 4V$ to $\pm 18V$ | 10 16 | 10 — | 10 20 | 10 — | 20 — | $\mu V/V$ MAX |
| Large-Signal Voltage Gain | A_{vo} | $R_L \geq 2k\Omega$, $V_O = \pm 10V$ $R_L \geq 1k\Omega$, $V_O = \pm 10V$ | 600 — | 1000 800 | 500 — | 1000 800 | 700 — | V/mV MIN |
| Output Voltage Swing | V_O | $R_L \geq 2k\Omega$ $R_L \geq 600\Omega$ | ± 11.5 — | ± 12.0 ± 10.0 | ± 11.0 — | ± 12.0 ± 10.0 | ± 11.5 ± 10.0 | V MIN |
| Power Consumption | P_d | $V_O = 0$ | — | 140 | — | 140 | 170 | mW MAX |

NOTES:

- For $25^\circ C$ characteristics of OP-37NT and OP-37GT devices, see OP-37N and OP-37G characteristics, respectively.

Electrical tests are performed at wafer probe to the limits shown. Due to

variations in assembly methods and normal yield after packaging is not guaranteed for standard product dice. Consult factory to negotiate specifications based on dice lot qualification through sample lot assembly and testing.

TYPICAL ELECTRICAL CHARACTERISTICS at $V_S = \pm 15V$, $T_A = 25^\circ C$, unless otherwise noted.

| PARAMETER | SYMBOL | CONDITIONS | OP-37NT TYPICAL | OP-37N TYPICAL | OP-37GT TYPICAL | OP-37G TYPICAL | OP-37GR TYPICAL | UNITS |
|------------------------------------|---------------------------|---|--------------------|-------------------|--------------------|-------------------|--------------------|-----------------|
| Average Input Offset Voltage Drift | TCV_{os} or TCV_{osn} | Nulled or Unnulled $R_p = 8k\Omega$ to $20k\Omega$ | 0.2 | 0.2 | 0.3 | 0.3 | 0.4 | $\mu V/\circ C$ |
| Average Input Offset Current Drift | $TClos$ | | 80 | 80 | 130 | 130 | 180 | pA/ $\circ C$ |
| Average Input Bias Current Drift | TCI_B | | 100 | 100 | 160 | 160 | 200 | pA/ $\circ C$ |
| Input Noise Voltage Density | e_n | $f_0 = 10Hz$ $f_0 = 30Hz$ $f_0 = 1000Hz$ | 3.5 3.1 3.0 | 3.5 3.1 3.0 | 3.5 3.1 3.0 | 3.5 3.1 3.0 | 3.8 3.3 3.2 | $nV\sqrt{Hz}$ |
| Input Noise Current Density | i_n | $f_0 = 10Hz$ $f_0 = 30Hz$ $f_0 = 1000Hz$ | 1.7 1.0 0.4 | 1.7 1.0 0.4 | 1.7 1.0 0.4 | 1.7 1.0 0.4 | 1.7 1.0 0.4 | pA \sqrt{Hz} |
| Input Noise Voltage | e_{np-p} | 0.1Hz to 10Hz | 0.08 | 0.08 | 0.08 | 0.08 | 0.09 | μV_{p-p} |
| Slew Rate | SR | $R_L \geq 2k\Omega$ | 17 | 17 | 17 | 17 | 17 | V/ μs |
| Gain Bandwidth Product | GBW | $f_0 = 10Khz$ | 63 | 63 | 63 | 63 | 63 | MHz |

NOTES:

- Input offset voltage measurements are performed by automated test equipment approximately 0.5 seconds after application of power.

ORDERING INFORMATION

| $T_A = 25^\circ C$ V_{osMAX} (μV) | PACKAGE | | | | | OPERATING TEMP RANGE |
|--|----------------------------|--------------------------|-------------------------|------------------------------|-----|--|
| | HERMETIC TO-99 8-PIN | HERMETIC DIP 8-PIN | PLASTIC DIP 8-PIN | PLASTIC SO-JEDEC 8-PIN | LCC | |
| 25 | OP37AJ | OP37AZ | | | | MIL IND./COM. MIL IND./COM. MIL IND./COM. |
| 25 | OP37EJ | OP37EZ | OP37EP | OP37ES | | |
| 60 | OP37BJ | OP37BZ | | | | |
| 60 | OP37FJ | OP37FZ | OP37FP | OP37FS | | |
| 100 | OP37CJ | OP37CZ | | | | |
| 100 | OP37GJ | OP37GZ | OP37GP | OP37GS | | |
| OP37BRC/88 | | | | | | |